## Notice of References Cited Application/Control No. 10/666,189 Applicant(s)/Patent Under Reexamination HAMMAN, BRIAN A. Examiner Anatoly Vortman Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,791,834	09-2004	Nakagawa et al.	361/687
	В	US-5,383,340	01-1995	Larson et al.	62/259.2
	С	US-5,339,214	08-1994	Nelson, Daryl	361/695
	D	US-6,250,378	06-2001	Kobayashi, Takashi	165/104.33
	Ε	US-6,097,597	08-2000	Kobayashi, Takashi	361/687
	F	US-5,606,341	02-1997	Aguilera, Rafael E.	345/87
	G	US-6,234,240	05-2001	Cheon, Kioan	165/80.3
	Н	US-6,751,095	06-2004	Ishikawa et al.	361/687
	ı	US-5,634,351	06-1997	Larson et al.	62/259.2
	J	US-5,764,483	06-1998	Ohashi et al.	361/699
	К	US-4,610,222	09-1986	Goddard et al.	123/41.42
	L	US-5,323,847	06-1994	Koizumi et al.	165/104.33
	М	US-5,731,954	03-1998	Cheon, Kioan	361/699

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N							
	0							
	Р							
	Q							
	R							
	S							
	T							

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	•
	W	
	x	

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